Q

PRODUCT SPECIFICATION

PS-7755

Rev. AX10

Title: Mini Cool Edge IO Integrated Connector For PCle Type

Product Specification

Part Number: G97 series

Mini Cool Edge IO Integrated Connector,

Description: 0.6 Pitch, SMT Type

Revisions Control

Rev.	ECN Number	Originator	Approval	Issue Date
AX5	NA	Sondra Sang		06.22.2020
AX6	NA	Joan Lu		07.18.2020
AX7	NA	Sondra Sang		11.11.2020
AX8	NA	Sondra Sang		06.15.2021
AX9	NA	Joan Lu		07.21.2021
AX10	NA	Joan Lu		05.10.2022

Product Specification Origination

Originator:	Date:	Checked by:	Date:	Approved by:	Date:
Joan Lu	05.10.2022	Sondra Sang	05.10.2022	Hank Hsu	05.10.2022

This document is the property of Amphenol Corporation and is delivered on the express condition that it is not to be disclosed, reproduced or used, in whole or in part, for manufacture or sale by anyone other than Amphenol Corporation without its prior consent, and that no right is granted to disclose or to use any information in this document.

PS-7755

Rev. AX10

1. Scope

This document defines the detailed requirements for the Amphenol G97 Series Mini Cool Edge IO integrated for PCIe type connector to insure functionality and reliability.

2. Applicable documents

2.1 EIA-364 Standard Test methods for electrical connectors

2.2 UL-STD-94 Tests for flammability of plastic materials for parts in devices

and appliances.

2.3 PCI Express Card PCI EXPRESS, Revision 5.0, Version 0.9

3. Requirements

3.1 Design and construction

Product shall be of the design, construction and physical dimensions specified on the applicable product drawing.

3.2 Material and finish

- 3.2.1 Housing
 - High temperature thermoplastic, UL94V-0
 - Color: Black
- 3.2.2 Contact
 - Copper Alloy
 - Contact area: Selected Gold plating
 - Solder area: Matte Tin plating
 - Under-plating: Nickel plating overall

3.2.3 Shell

Stainless steel

Solder area: Nickel under-plated overall

3.3 Rating

Current: 1.1 A per pin up to 6 pairs

Voltage: 30 VDC per contact

Temperature:

Operating: -40°C~ 105°C Non-operating: -55°C~ 105°C



Sheet 3 of 8

PRODUCT SPECIFICATION

PS-7755

Rev. AX10

4. Performance and testing

4.1 Test requirements and procedures summary

Test	Test procedure			Tes	st criteria		
Visual & Dimensional inspection	EIA-364-18 Visual, dimensional and func- inspection.	Must meet the minimum requirements specified by product drawing.					
Electrical:							
Low level Contact Resistance	EIA-364-23 Current : 100 mA maximum Voltage : 20 mV maximum	Initial: Baseline After test: ΔR=20 milliohms maximum					
Dielectric Withstanding Voltage	EIA-364-20 Apply a voltage between adjuterminals. Voltage: 300 VDC Duration: 1 minute	acent	No defect or breakdown No disruptive discharge No leakage current in excess of 0.5mA				
Temperature Rise (via current cycling)	EIA-364-70 Measure the temperature at the rated current. Ambient temperature: 25°(up to a maximum of 6 adja pins per side, 12 pins tota	C acent	30°C maximum change from initial				
Insulation Resistance	1000M Ω minimum		EIA-364-21 Test voltage 100V DC. Duration: 1 minute Measure between adjacent signal contacts.				
High Speed Electric	cal Requirements:						
Line Rate	Insertion Loss	Retu	n Loss		Crosstalk		
PCIe 5	-1.5 dB at 16GHz	-10 dl	B at 16GHz		-40 dB at 16GHz		
Mechanical:				l			
Durability (preconditioning)	EIA-364-09 20 unmate/mate cycles		No evidence of physical damage.				
Durability	EIA-364-09 Cycle rate: 500±50 per ho Number of cycles: 200 cycles for 30µ" Au pla 100 cycles for 15µ" Au pla	No evidence of physical damage.					

8

PRODUCT SPECIFICATION

PS-7755

Rev. AX10

Mating Force (Module only)	EIA-364-13 Rate: 25.4 mm/minute	1.1 N Max./per pair pin
, ,		
Un-mating Force (Module only)	EIA-364-13 Rate: 25.4 mm/minute	0.1 N Min./per pair pin
Active Latch Retention Strength	EIA-364-13 Rate: 25.4 mm/minute Pull in direction parallel to insertion, hold for minimum of 60 seconds	50 N minimum
Wrenching strength (W/ mated Cable- Passive Latch)	Bend cable 90° at minimum bend radius. Pull in 4 axis directions for round cable. Pull in 2 axis directions for flat cable. No damage to plug/ cable assembly.	25 N minimum
Wrenching strength (W/ mated Cable- Active Latch)	Bend cable 90° at minimum bend radius. Pull in 4 axis directions for round cable. Pull in 2 axis directions for flat cable. No damage to plug/ cable assembly.	40 N minimum
Contact Normal Force	EIA-364-04 Rate: 25.4 mm/minute	0.49 N (50 grams) minimum at nominal
Vibration	EIA-364-28, Test Condition VII, Condition D Subject mated specimens to 3.10 G's rms between 20-500 Hz for 15 minutes in each of 3 mutually perpendicular planes.	No Damage No discontinuity longer than 1usec allowed. 20 milliohms maximum change from initial (baseline) contact resistance
Mechanical Shock	EIA-364-27, Test Condition H Subject mated specimens to 50 G's half-sine shock pulses of 11 milliseconds duration. 3 shocks in each direction applied along 3 mutually perpendicular planes, 18 total shocks.	No Damage 20 milliohms maximum change from initial (baseline) contact resistance
Reseating	Manually unmate/mate the connector 3 cycles.	No evidence of physical damage.

This document is the property of Amphenol Corporation and is delivered on the express condition that it is not to be disclosed reproduced or used, in whole or in part, for manufacture or sale by anyone other than Amphenol Corporation without its prior consent, and that no right is granted to disclose or to use any information in this document.

PS-7755

Rev. AX10

Environmental:		<u> </u>
Thermal Shock EIA-364-32, Method A Test condition 1 -55 °C to 85 °C, perform 5 cycles in mating condition		No Damage 20 mOhms maximum change from initial (baseline) contact resistance
Humidity- Temperature Cycling	EIA-364-31, Method III	No Damage 20 mOhms maximum change from initial (baseline) contact resistance
Temperature Life (preconditioning)	EIA-364-17, Method A Subject mated specimens to 105°C for 72 hours	No Damage
Temperature Life	EIA-364-17, Method A Test Condition 2, Test Time Condition C Subject mated specimens to 105°C for 120 hours	No Damage 20 mOhms maximum change from initial (baseline) contact resistance
Mixed flowing gas (MFG)	EIA-364-65, class IIA Test condition: mated connector. RH: 70±2% Temperature: 30±1°C Cl₂: 10±3 ppb NO₂: 200±50 ppb H₂S: 10±5 ppb SO2: 100±20 ppb Duration: 7 days	No evidence of physical damage
Salt Spray	EIA-364-26B Test condition: mated connector. a.) 5±1% salt. b.) temperature :35±2°C. c.) Duration: 48 hours.	No evidence of physical damage LLCR Initial: baseline After test: ΔR=20 milliohms maximum
Solderability	J-STD-002E Test Method A1: Temp:245°C±5° C, Immerse and withdraw at 1 mm - 5 mm, per second and dwell for 5 +0/-0.5 seconds, Leads and terminations shall	95% of immersed area must show no volids or pin holes.



Amphenol Taiwan Corporation

Sheet 6

of

8

PRODUCT SPECIFICATION

PS-7755

Rev. AX10

	have flux applied uniformly and to cover the surfaces to be tested.	
Resistance to soldering heat (Infrared reflow)	EIA-364-29 Average ramp rate: 1~4°C per second Temperature(board surface): 250 +10°C/-0°C Duration:30~35 seconds	No evidence of physical damage

PS-7755

Rev. AX10

4.2 Test Sequence

Test or Examination		Test Groups												
rest or Examination	Α	В	С	D	Е	F	G	Н	I	J	K	L	М	N
Examination of connector(s)	1,8	1,10	1,10	1,12	1,9	1,3	1,7	1,5	1,3	1,3	1,3	1,3	1,3	1,3
Current Rating						2								
LLCR	2,5,7	2,5,7,9	2,5,7,9	2,5,7 9,11	4,6			2,4						
Insulation Resistance					3,8									
Dielectric Withstanding Voltage					2,7									
Durability					5									
Durability (Preconditioning)	3	3	3	3										
Matting/un-mating Force							3,6							
Reseating	6	8		10			2,5							
Thermal Shock		4												
Humidity-Temperature Cycling		6												
Thermal disturbance				8										
Temperature Life	4						4							
Temperature Life (Preconditioning)			4	4										
Mechanical Shock			8											
Vibration			6											
Salt Spray								3						
Mix Flowing Gas(MFG)				6										
Solder ability									2					
Resistance to Soldering Heat										2				
Active Latch Retention Strength											2			
Contact Normal Force												2		
Wrenching strength(W/mated cable-passive Latch)													2	
Wrenching strength(W/mated cable-active Latch)														2
Sample size	5	5	5	5	5	5	5	5	5	5	5	5	3	3

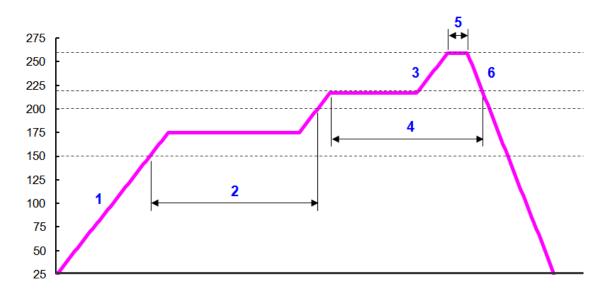
Note:

- 1. Test specimen: 5 PCS/ group unless otherwise specified.
- 2. Test specimen shall be sure to meet the drawing before the testing.

PS-7755

Rev. AX10

4.3 Recommended IR reflow profile(Lead-free)



1, 3	Average ramp-up rate	3°C/second max.
2	Preheat	
	- Temperature Min	150°C
	- Temperature Max	200°C
	- Pre-heat time	60-180 seconds
4	Time maintained above	
	- Temperature	217°C
	- Time	60-150 seconds
5	Peak temperature	260°C
	Time within 5°C of actual peak	20-40 seconds
6	Ramp-down Rate	6°C/second max.
	Time 25°C to peak Temperature	8 minutes max.